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Examiner

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**Applicant(s)/Patent under
Reexamination**

DUBEY ET AL.

Art Unit

1791

SEARCHED

Class	Subclass	Date	Examiner
UPDATED		5/13/2008	EHL

INTERFERENCE SEARCHED

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264	128,308	5/13/2008	EHL
	333		
	172.19		
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**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

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